

**Search Notes**

Application/Control No.

10/540,147

Examiner

Benny Lee

Applicant(s)/Patent under  
Reexamination

LO HINE TONG ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
333	206,222, 245	12/29/2006	BTL
29	600	12/29/2006	BTL
Rsch	abovr	6/29/2007	BTL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR